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**PATENTS**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

**APPLICANT** : WEI, Kung-Hwa et al      **ATTY DOCKET** : BA-22878  
**SERIAL NO.** : 10/828,435  
**FILED** : April 20, 2004  
**FOR** : COVALENTLY BONDED POLYHEDRAL OLIGOMERIC  
SILSESQUIOXANE/ POLYIMIDE NANOCOMPOSITES AND  
PROCESS FOR SYNTHESIZING THE SAME

**INFORMATION DISCLOSURE STATEMENT**

MAILSTOP: NON-FEE AMENDMENT  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

S I R :

Enclosed, please find copies of five (5) articles, which are also listed on the attached PTO-form 1449.

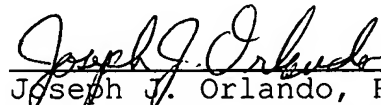
These articles are cited in the specification on page 3, and are enclosed herewith.

Since this Information Disclosure Statement is being filed prior to a first Office Action, it is believed that no fee is due. However, if it is determined that a fee is due, the Commissioner is hereby authorized to charge our deposit account number 03-2468, without further authorization.

It is respectfully requested that this Information Disclosure Statement be considered and placed into the application file.

Respectfully submitted,

KUNG-HWA WEI, ET AL.



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I hereby certify that this document is being deposited with the U.S. Postal Service on June 7, 2004, as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

  
Maria Guastella

FORM PTO-1449  
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO. :  
BA-22878

SERIAL NO. 10/828,435

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

APPLICANT: Kung-Hwa WEI ET AL

FILING DATE: 4/20/2004

GROUP:

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AQ		Eashoo, M.; Buckley, L.J.; StClair, A.K. <i>J. Polym. Sci. Part B: Polym. Phys.</i> , 1997, 35, 173
	AR		Hedrick, J.L.; Miller, R.D.; Hawker, C.J.; Carter, K.R.; Volksen, W.; Yoon, D.Y.; Trollsas, M. <i>Adv. Mater.</i> , 1998, 10, 1049
	AS		Carter, K.R.; DiPietro, R.A.; Sanchez, M.I.; Russell, T.P.; Lakshmanan, P.; McGrath, J.E. <i>Chem. Mater.</i> 1997, 9, 105
	AT		Hedrick, J.L.; Carter, K.R.; Richter, R.; Miller, R.D.; Russell, T.P.; Flores, V. <i>Chem Mater.</i> 1998, 10(1), 39
	AU		Carter, K.R.; DiPietro, R.A.; Sanchez, M.I.; Swanson, S.A. <i>Chem. Mater.</i> , 2001, 13, 213

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.